



Name: _____ (print) Email: _____ (print)

Instrument	Selection/Required Course work	Experience	User Status	Initials and Date Staff Responsible for instrument	Date on User list
Hitachi S4700 B18-C McNutt Hall	<input type="checkbox"/> Met 5520- Scanning Electron Microscopy & X-ray microanalysis or previous experience	6 hours of S4700 use in the past 3 months	Supervised		
			Unsupervised		
FEI Helios 600 B18-A McNutt Hall	<input type="checkbox"/> Met 5520- Scanning Electron Microscopy & X-ray microanalysis or previous experience	6 hours of Helios 600 use in the past 3 months	Supervised		
			Unsupervised		
FEI Tecnai F20 B18-B McNutt Hall	<input type="checkbox"/> Met 5530- Transmission Electron Microscopy & X-ray microanalysis or previous experience	6 hours of Tecnai F20 use in the past 3 months	Supervised		
			Unsupervised		

If supervised user, status will be upgraded to unsupervised user upon completion of:

- S4700 Experience Observation Test
- Helios FIB EBSD Experience Observation Test
- Tecnai Experience Observation Test

This approved user status will remain in effect as long as a minimum of 20 hours of use is recorded in any 6 month period.

This approved status is granted with the understanding that, in the unlikely event that the instrument operator is unavailable due to unforeseen circumstances, the above named researcher may be asked to temporarily operate the instrument for other users who are not unsupervised users.

Any misuse of this privilege will result in revocation of this status. Misuse includes, but is not limited to habitual tardiness for sessions, missed sessions, misuse of the instrument in any manner, allowing unauthorized users to operate equipment, or failure to log usage hours.

APPROVED:

 (Staff member responsible for instrument) (Signature) Date: _____

 (Advisor name) (Signature) Date: _____

Dr. F. Scott Miller _____
 (Director, AMCL) (Signature) Date: _____

Dr. Matt O'Keefe _____
 (Director, MRC) (Signature) Date: _____